


Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	AT&T DOCKET NO. 208387US2	SERIAL NO. 09/855,665				
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Hideaki YAMAGATA, et al.					
		FILING DATE May 16, 2001	GROUP 2621				
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
15	AW	Whoi-Yul KIM, et al., IEEE, pages 391-396, "A PRACTICAL PATTERN RECOGNITION SYSTEM FOR TRANSLATION, SCALE AND ROTATION INVARIANCE", 1994					
15	AX	Hai LIN, et al., IEEE, pages 2963-2967, "CHINESE SIGNATURE VERIFICATION WITH MOMENT INVARIANTS", 1996					
15	AY	P. SANGASSAPAVIRIYA, et al., IEEE TENCON-Speech and Image Technologies for Computing and Telecommunications, pages 203-206, "SIMILARITY MEASURES FOR COMPRESSED IMAGE DATABASES", 1997					
	AZ						
Examiner 					Date Considered 5/04		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through conformance and not considered. Include copy of this form with next communication to applicant.							

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SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 208387US2		SERIAL NO. 09/855,665	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
1e	AA	5,796,869	08/18/98	M. TSUJI, et al.	382	203	
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15	AW	A. ELEFThERiADiS, et al., Signal Processing: Image Communication, vol. 7, no. 4, pages 435 - 455, "AUTOMATIC FACE LOCATION DETECTION FOR MODEL-ASSISTED RATE CONTROL IN H.261-COMPATIBLE CODING OF VIDEO", November 1, 1995					
15	AX	S. KUMAR, et al., Pattern Recognition, vol. 27, no. 8, pages 1019 - 1028, "PARALLEL ALGORITHMS FOR CIRCLE DETECTION IN IMAGES", August 1, 1994					
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Examiner 					Date Considered 5/7/04		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
208387US2SERIAL NO.
NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hideaki YAMAGATA, et al.

FILING DATE
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GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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IS	AB	5,642,106	06/24/97	Thomas R. HANCOCK, et al.	340	988	
IS	AC	4,748,676	05/31/88	Michiaki MIYAGAWA, et al.	382	288	
IS	AD	6,018,990	02/01/00	Nobuaki UEKI	73	104	
IS	AE	5,987,162	11/16/99	Masafumi NAKATA	382	152	
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
IS	AO	11-110562	04/23/99	JAPAN (w/English Abstract) G06T 7/00 AS622417	*—
IS	AP	08-279021	10/22/96	JAPAN (w/English Abstract) G06K 9/32 Mach. Trans.	*—
IS	AQ	09-147109	06/06/97	JAPAN (w/English Abstract) G06T 7/00 Mach. Trans.	*—
IS	AR	08-115022	05/07/96	JAPAN (w/English Abstract) G03G 2/04 Mach. Trans.	*—
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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Examiner

Date Considered

5/04

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05/16/01